

De-embedding test fixtures for high speed digital applications

Joern Pfeifer
Application Engineer Vector Network Analyzer

ROHDE & SCHWARZ

Make ideas real



Jörn Pfeifer

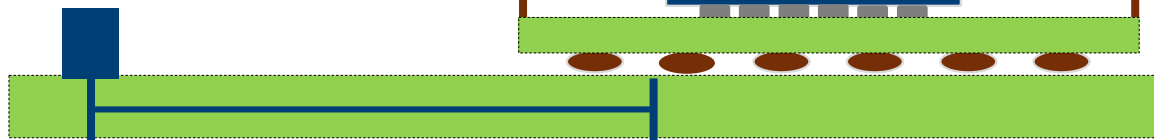
- ▶ Application Engineer
Vector Network Analyzer
- ▶ With Rohde & Schwarz since 2016
- ▶ R&S High Speed Data Link
Expert Core Team Member
- ▶ Open Alliance Automotive Ethernet TC9
Working group contributing member



Agenda

- ▶ Why use de-embedding in high speed digital scope measurements
- ▶ VNA and S-parameter measurement basics
- ▶ How to create fixture modelling files with a VNA
- ▶ Automotive Ethernet VNA De-embedding example

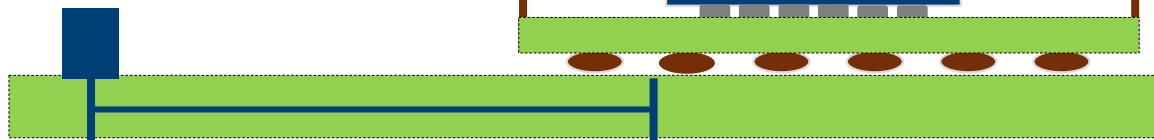
De-embedding test fixtures for high speed digital applications



Agenda

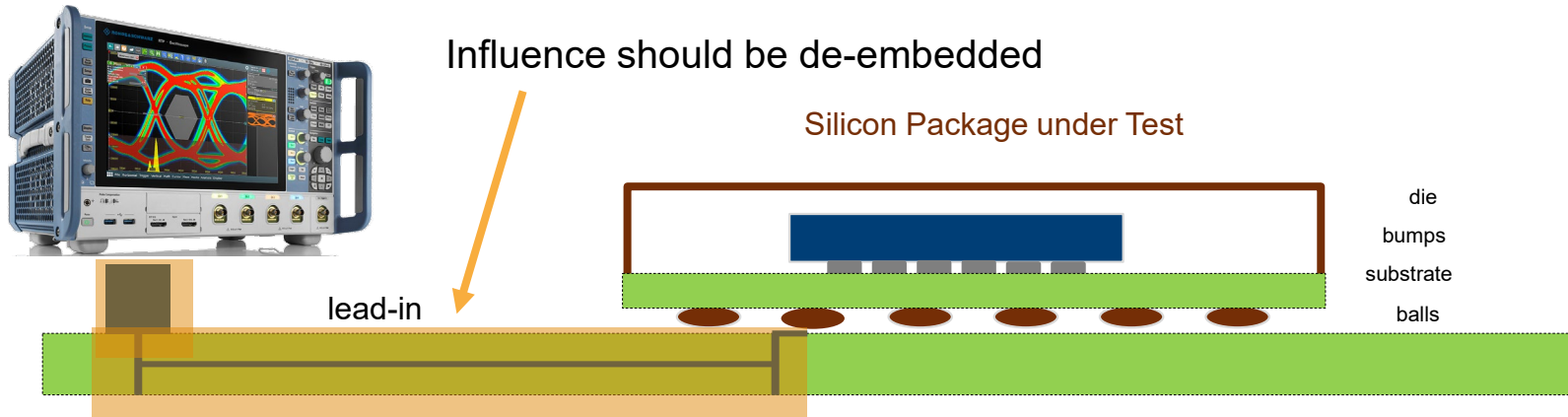
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Compensation of fixture influence for Oscilloscope transmitter test

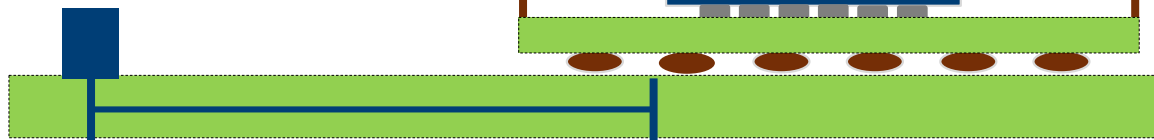
- ▶ Task is to measure a transmitter signal without influence of your fixture
- ▶ For a differential signal analysis symmetry of the measurement setup is key
- ▶ De-skew of oscilloscope channels (not scope of this presentation)
- ▶ A Vector Network Analyzer (VNA) can create fixture de-embedding files for compensation
- ▶ Loading created file in the Oscilloscope for compensation



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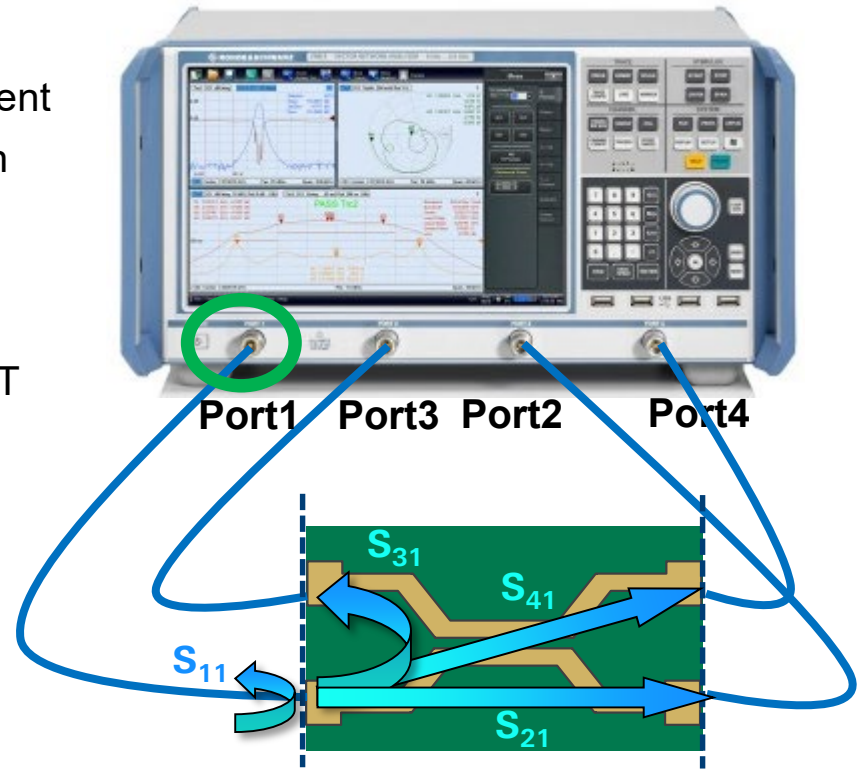
VNA and S-parameter basics

- ▶ VNAs combine source and receiver in one device
- ▶ Typically continuous frequency sweep measurement
- ▶ Measure S-parameter, reflection and transmission behavior of components
- ▶ Each port needs to be the driving port once
- ▶ In total four sweeps needed to create a full S-parameter characterization of a 4-port DUT

S_{11}	S_{12}	S_{13}	S_{14}
S_{21}	S_{22}	S_{23}	S_{24}
S_{31}	S_{32}	S_{33}	S_{34}
S_{41}	S_{42}	S_{43}	S_{44}

receiving port

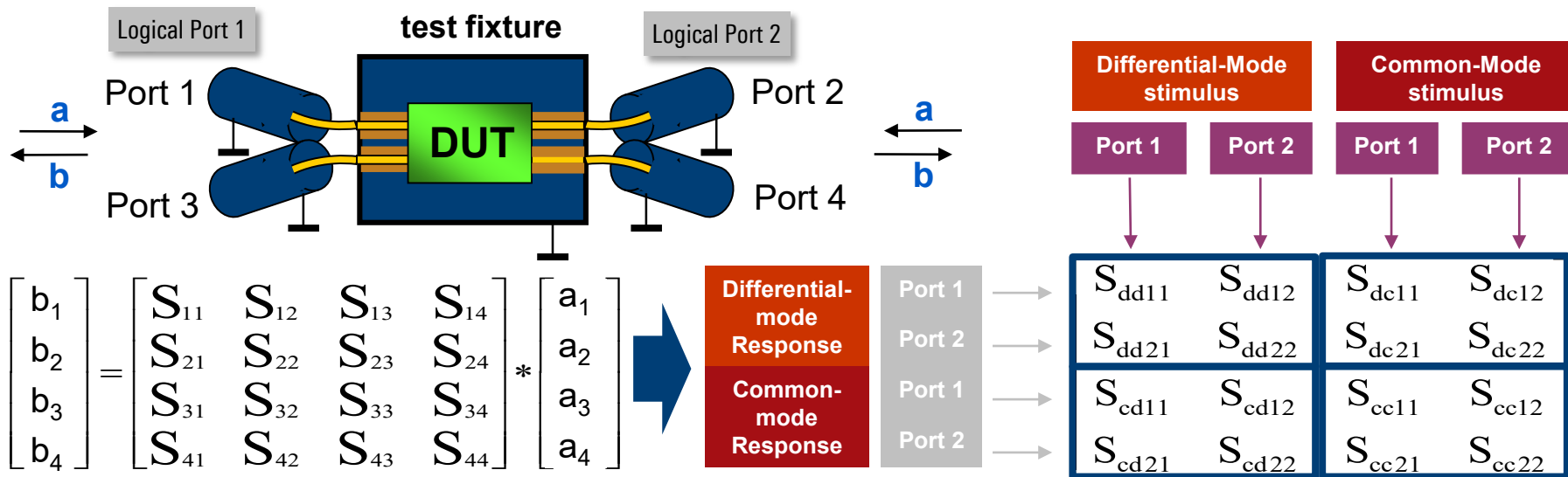
driving port



Balanced/ Mixed Mode S-Parameters

Measure the balanced 2-port device as unbalanced 4-port device with unbalanced VNA.
VNA Calculates mixed mode S-Parameters out of measured single ended S-Parameters.

a, b = power waves



S_{mm} = Reflection at Port m

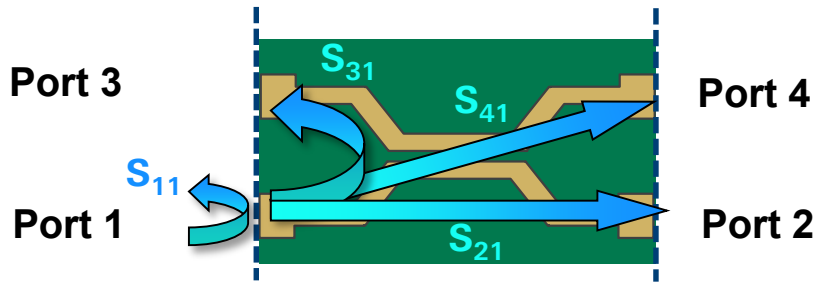
S_{mn} = Transmission from Port n to Port m

Naming Convention: S mode res., mode stim., port res., port stim.

What is a Touchstone File *.snp? (n is number of ports)

- ▶ Industry standard for S-parameter files
- ▶ Full description of frequency response of a component
- ▶ Complex values in *magnitude / angle (phase)* or *real / imag*
- ▶ One set of S-parameters per frequency point

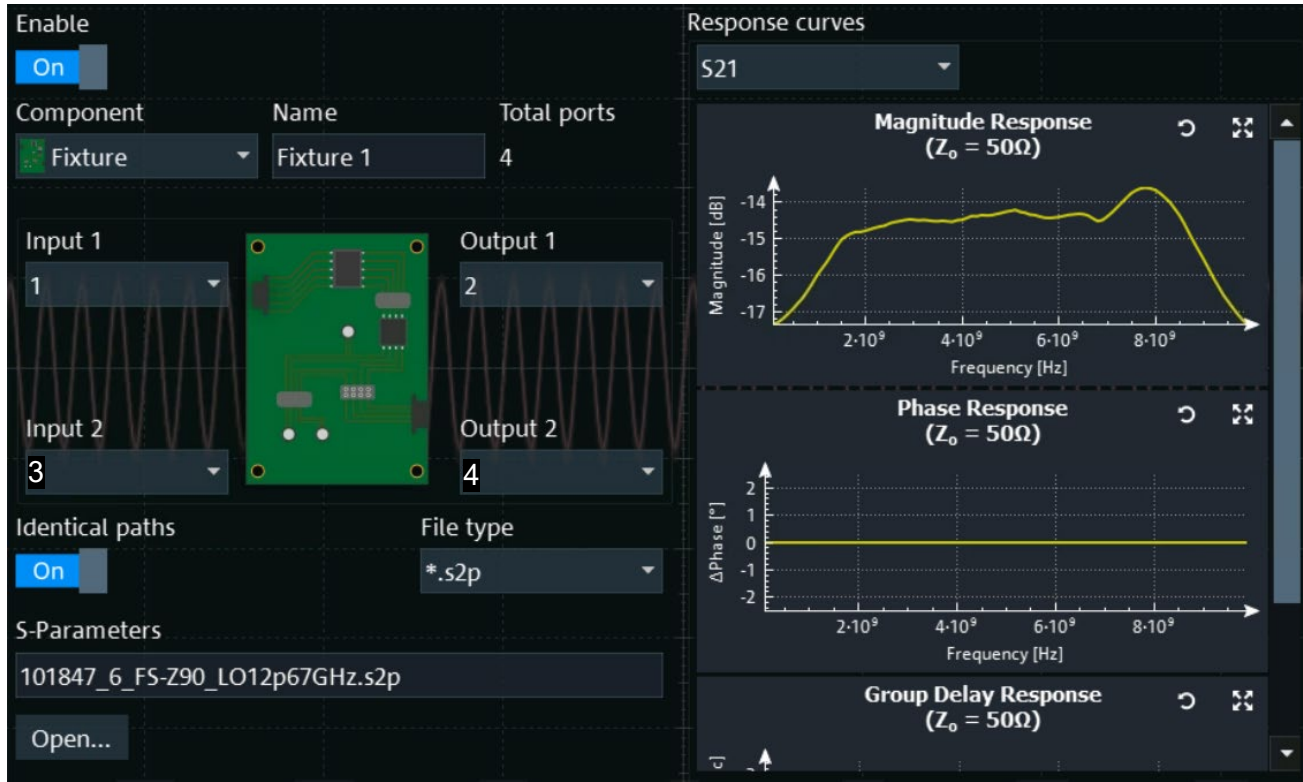
S_{11}	S_{12}	S_{13}	S_{14}
S_{21}	S_{22}	S_{23}	S_{24}
S_{31}	S_{32}	S_{33}	S_{34}
S_{41}	S_{42}	S_{43}	S_{44}



Take care about consistent port assignments during creation and use in VNA and Scope

```
# HZ S DB R 50.00
! Rohde & Schwarz Vector Network Analyzer
! Rohde-Schwarz,ZNB8-4Port,1311601044103485,2.94
! Created: UTC 6/5/2020, 8:58:28 AM
freq[Hz] db:S11 ang:S11 db:S12
db:S21 ang:S21 db:S22
db:S31 ang:S31 db:S32
db:S41 ang:S41 db:S42
1.000000000000000E6 7.030191930505213E-3 2.602916756534536E-2 -1.147839
-1.079817243963495E2 -1.486860327997170E2 -4.416523
-1.129092361182286E2 6.909905623452955 -1.094483
-1.067097263043102E2 -8.517666928925952 -1.067053
2.000000000000000E6 6.680282270222103E-3 -5.620099899660941E-3 -1.056192
-1.053286425696122E2 -8.232411897211276E1 7.924377
-1.071932533652798E2 -2.784612316253055E1 -1.035747
-1.092420136717747E2 8.535329241291025E1 -1.231045
3.000000000000000E6 8.013858121994550E-3 9.440017586267023E-3 -1.108921
-1.196678687080890E2 8.309343598600998E1 -1.828560
-1.072067375081136E2 1.640301718588150E2 -1.132190
```

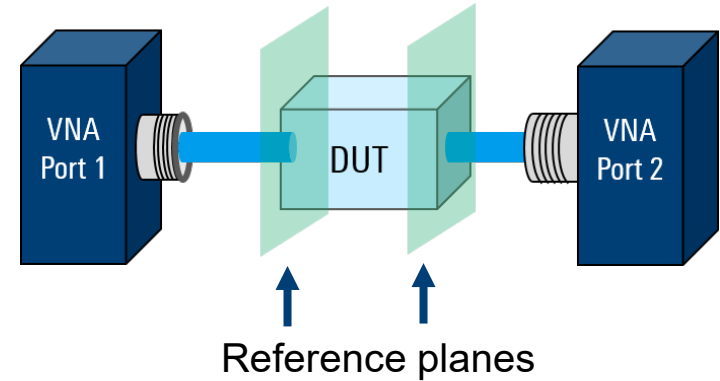
Scope import of S-parameter file for de-embedding



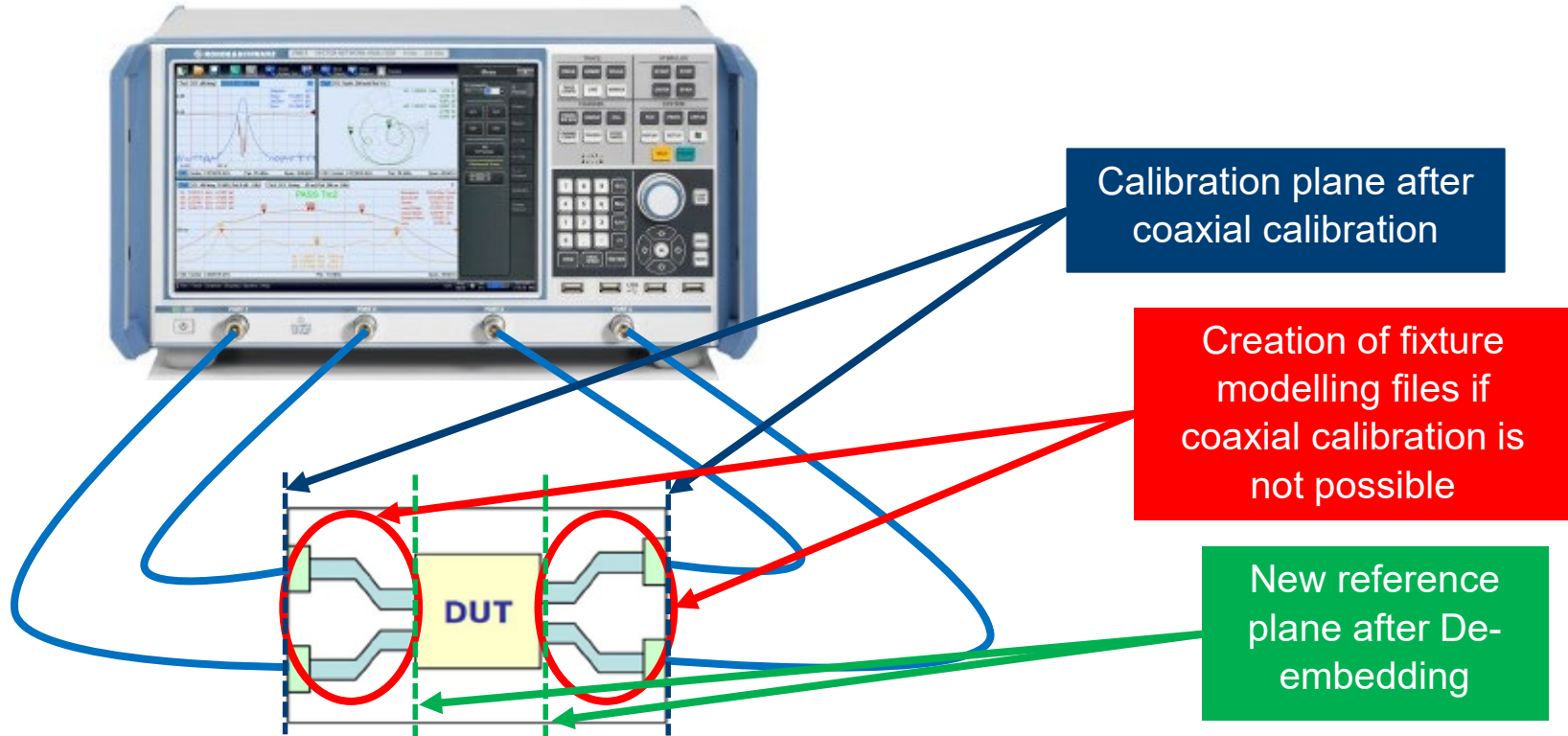
Take care about consistent port assignments during creation and use in VNA and Scope

VNA system error correction (calibration): coaxial interface

- ▶ Correction of systematic errors of the instrument and cables (test set)
- ▶ Reference plane: the point where the **known** calibration standards are presented, typically coaxial connector
- ▶ Typically used calibration kits consists of Through, Open, Short and Match standards (TOSM)
- ▶ Also automatic calibration units available
- ▶ Deembedding can be used when reference plane of DUT is not a coaxial connector



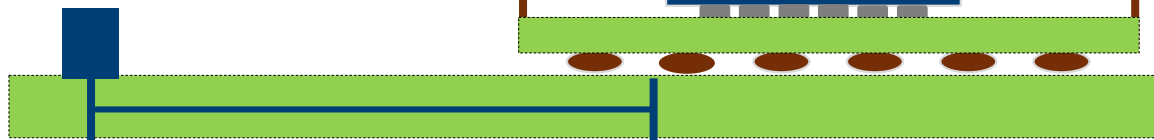
What if DUT does not have coaxial connectors?



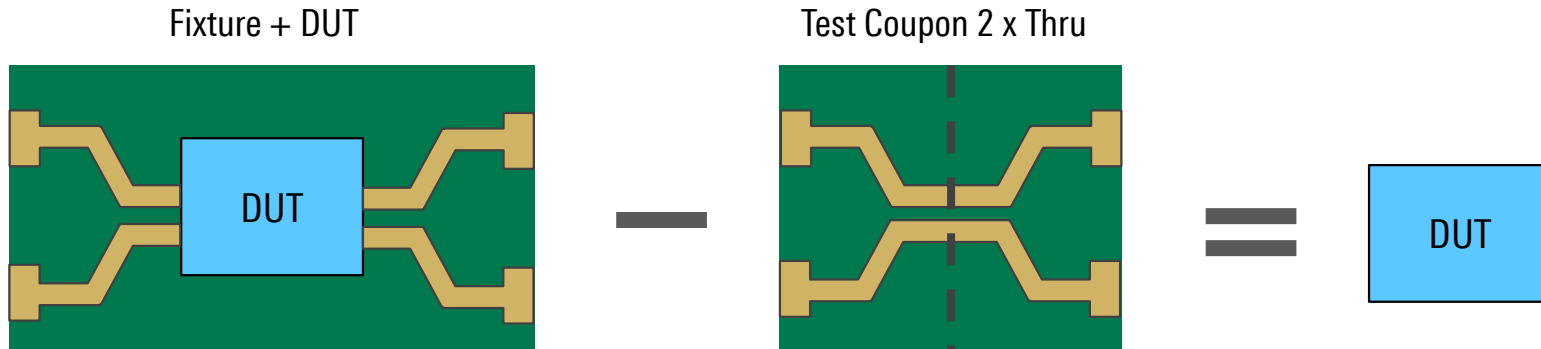
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Creation of de-embedding files for VNA measurements



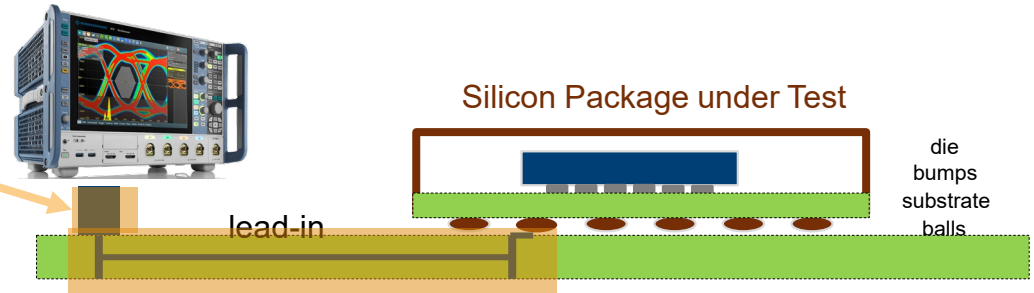
Lead-in traces

Lead-out traces

- ▶ Files can be created out of 2 x Thru itself
- ▶ Problem: Differences between coupon and test fixture would lead to errors (different connector and line impedances (e.g. fiber weave), different signal routing, etc.)
- ▶ Solution:
 - “Impedance Correction” feature creates fixture *.snp files out of Fixture + DUT measurement
 - Length of fixtures determined out of coupon measurement file
 - Two measurements needed: Coupon and Fixture + DUT measurement

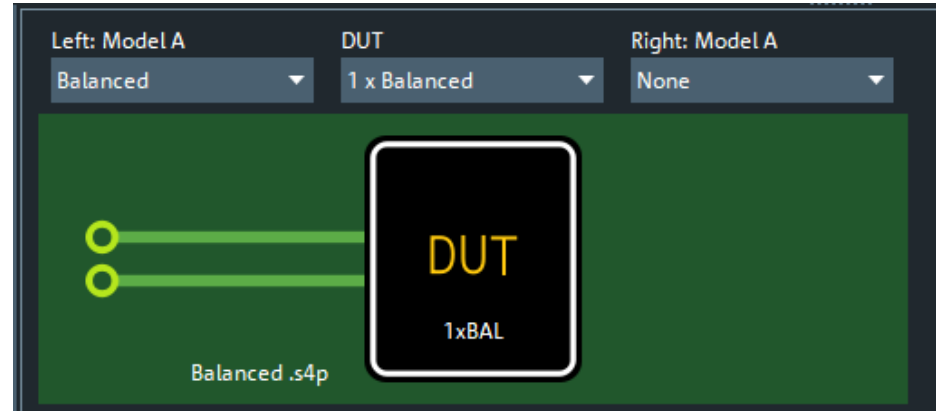
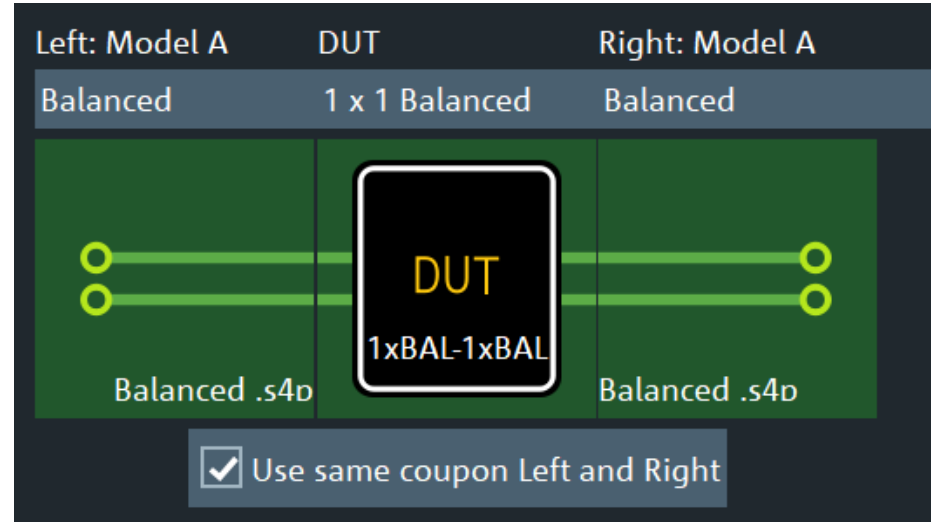
Creation of de-embedding files for scope measurements

- ▶ To be de-embedded for ideal scope measurements
- ▶ Without coaxial interface fixture cannot be measured directly with VNA
- ▶ Use VNA De-embedding tools to create fixture S-parameter file
- ▶ Choose Coupon:
 - 2 x Thru (replica)
 - 1 x Open (open fixture)
 - 1 x Short (shorted fixture)
 - 1 x Open + 1 x Short



R&S VNA de-embedding file creation

- ▶ Choose de-embedding use case
- ▶ Balanced / Single Ended
- ▶ Symmetric fixtures left/ right
- ▶ one port setup (FIX DUT) for Oscilloscope test case
- ▶ Also possible to create file with 1x Balanced (e.g. 1 x Open) only



R&S VNA de-embedding modeling file creation

Choose coupon type
(2x Thru, 1x Open ,...)

Impedance correction on / off *

On: → create fixture file from Fixture-DUT-Fixture

Off: → creates fixture files from coupon

Coupon A

1x Open

Open

Port
L1
P1, P3

.s2p

Measure Load...

Measure / Apply

Impedance Correction

Port
L1
P1, P3

DUT
1xBAL

* If coupon and fixture are different, try to use impedance correction

Measure Apply

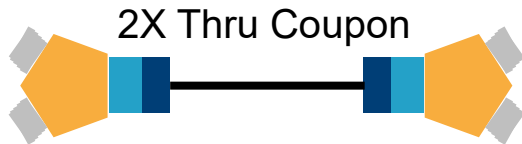
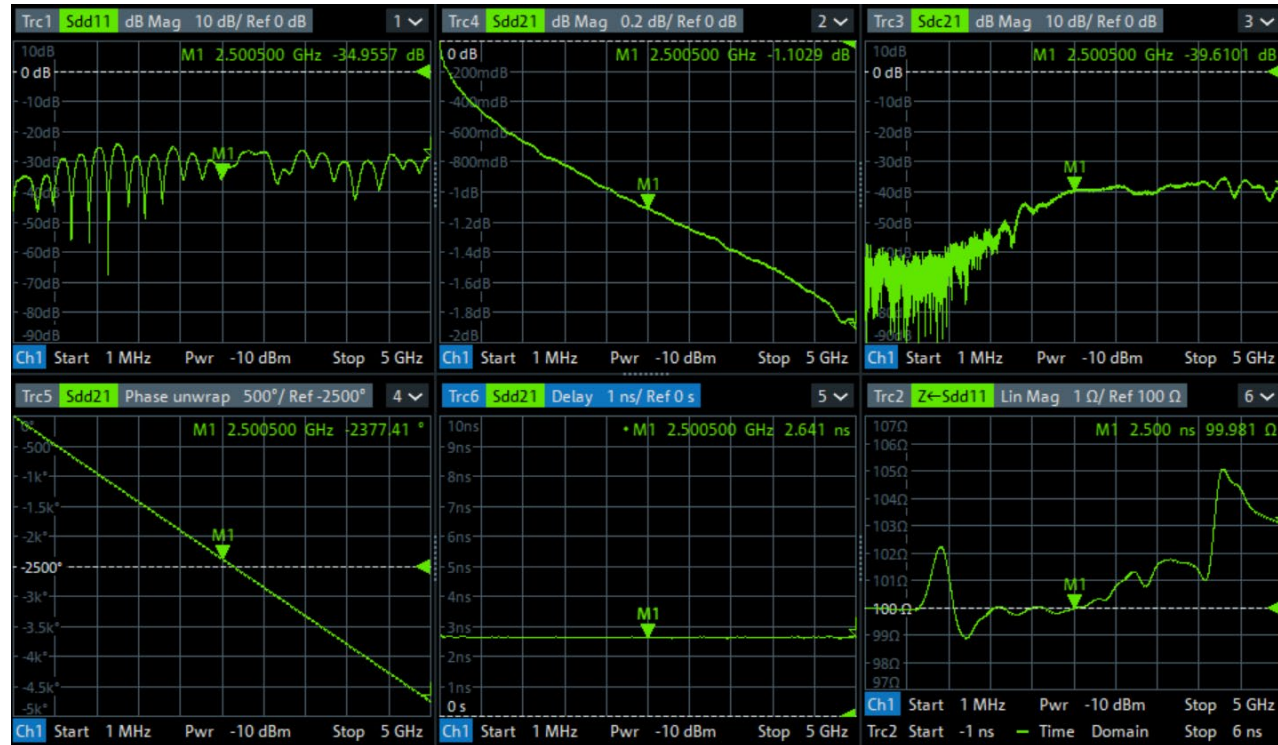
1: Measure or load
Coupon S-parameter

2: Measure
Fixture - DUT - Fixture

3: Create fixture
files

S-parameters of a transmission channel

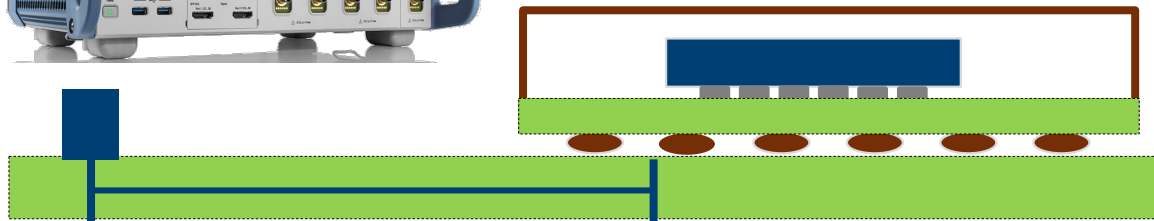
- ▶ Sdd11 Reflection in dB
- ▶ Sdd21 Transmission in dB
- ▶ Sdc21 Mode Conversion
- ▶ Sdd21 Phase
- ▶ Sdd21 Delay
- ▶ $Z \leftarrow Sdd11$ TDR Impedance



Agenda

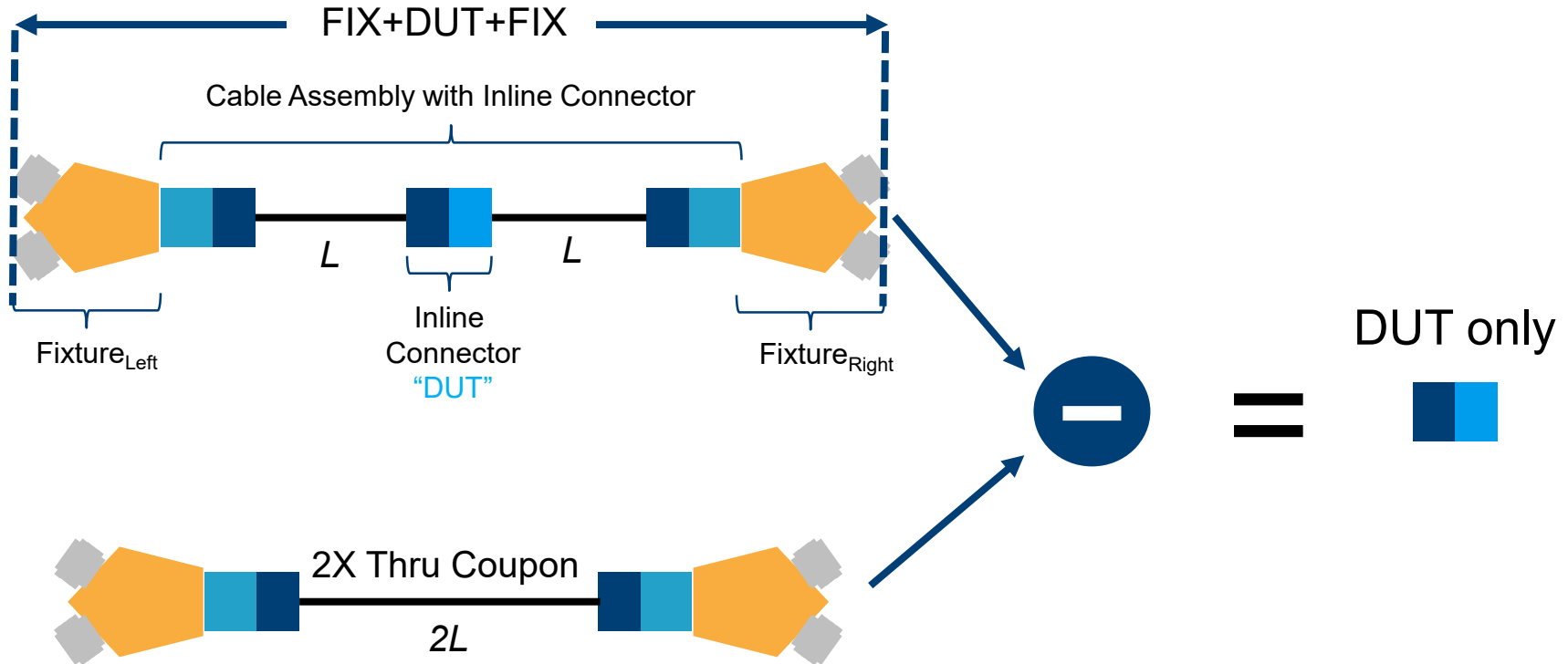
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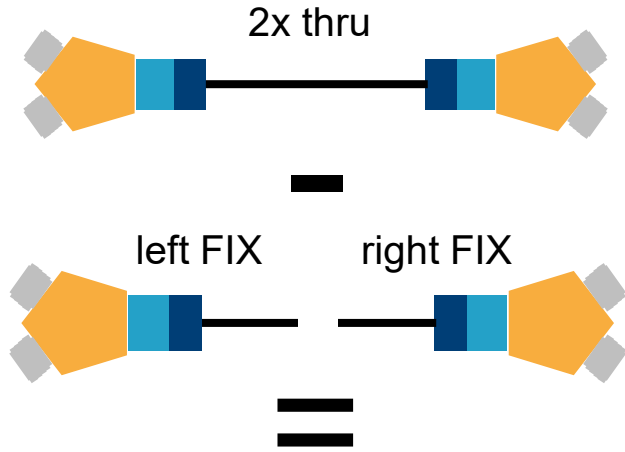


Automotive ethernet mated cable connector

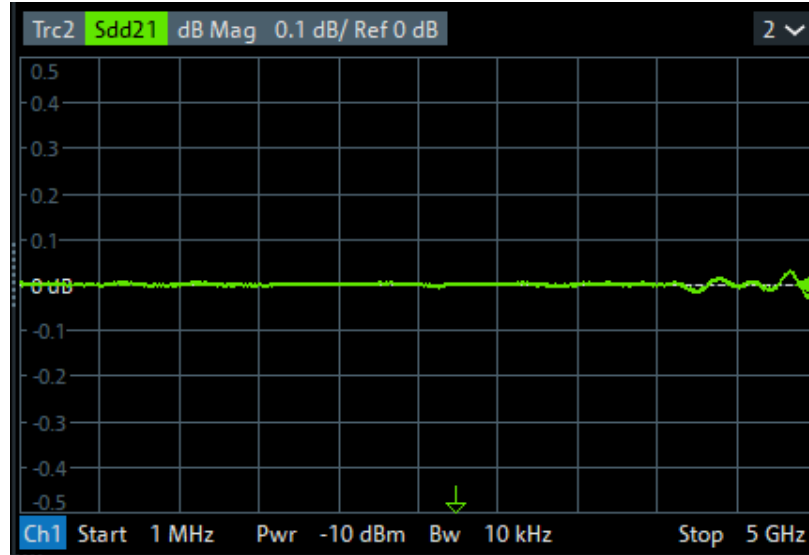
Impedance-corrected de-embedding



Self de-embedding of 2x Thru



“Ideal Thru”



IEEE370 S_{DD21}

Criteria:

Magnitude < +/- 0.1 dB
Phase < +/- 1°

Standard 2x Thru de-embedding

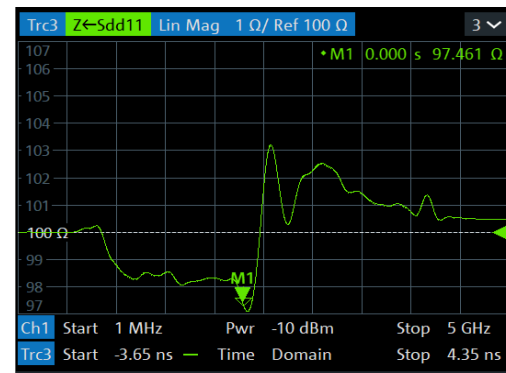
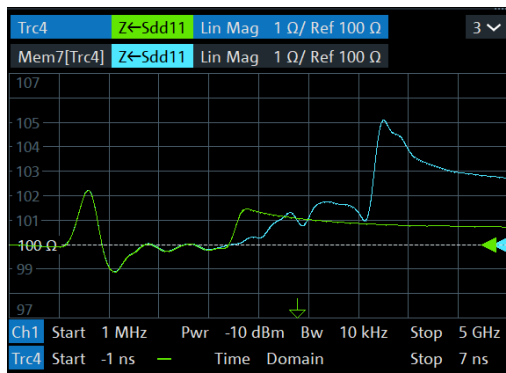
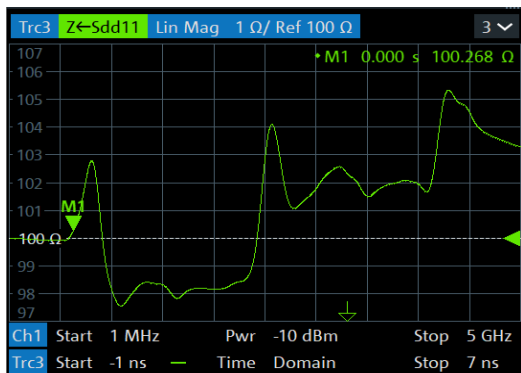
Fixture_{Left} + DUT + Fixture_{Right}



2X Thru



Fixture_{Left} + DUT + Fixture_{Right}



Whole 2xThru
Fixture_{Left} Generated Model

DUT
(including "Phantom limbs")

→ Bad result because TDR Impedance of 2x Thru is different than of FIX+DUT+FIX

Automotive ethernet mated cable connector Impedance-corrected de-embedding result

Fixture_{Left} + DUT + Fixture_{Right}



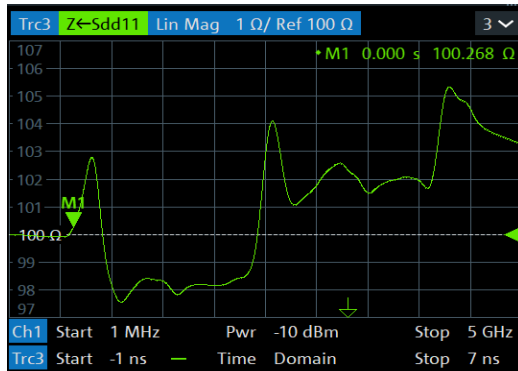
Fixture_{Left}



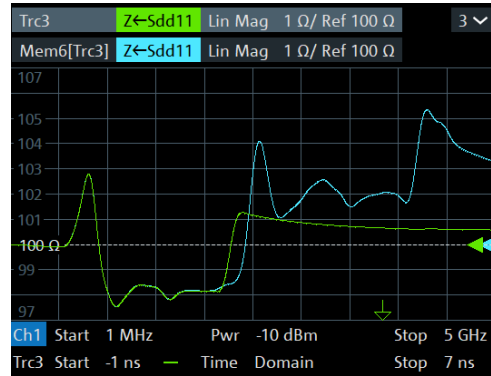
Fixture_{Right}



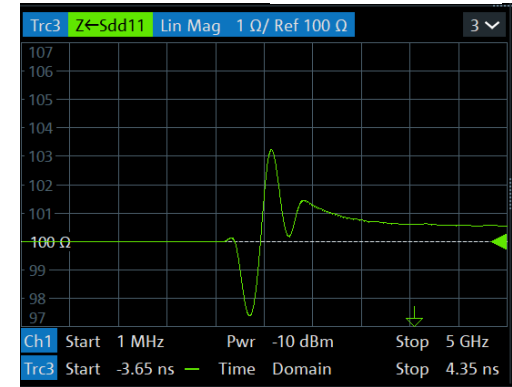
DUT



-



=



Fixture_{Left} + DUT + Fixture_{Right}
 Fixture_{Left} Generated Model

→ Perfect result: no influence of fixture left

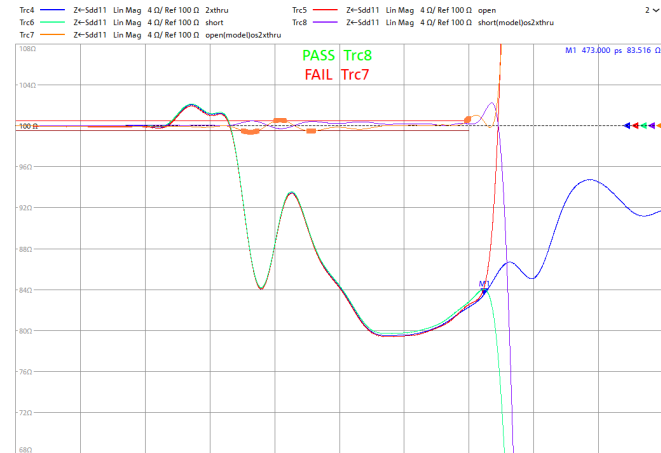
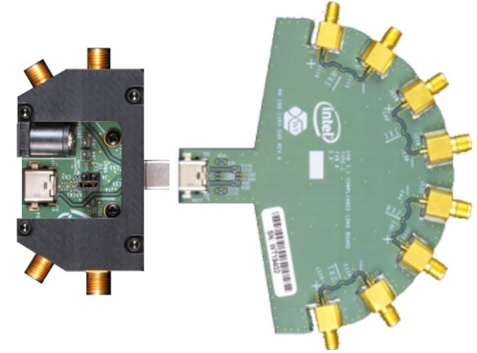
Conclusion

De-embedding test fixtures for high speed digital applications

- ▶ **Compensation of fixture** is needed
- ▶ **S-parameter de-embedding** is best way
- ▶ **Corrects** precisely the **frequency response** in reflection and transmission behaviour
- ▶ **Creation of precise fixture S-parameter files** with VNA
- ▶ A **coupon reference structure** is needed (1xOpen, 2xThru, ...)
- ▶ Use consistent **port assignments** of fixture file during creation and use

Upcoming Appnote: De-embedding test fixtures for high speed digital applications

- ▶ Used example is transmitter test USB 3.2 Type C
- ▶ Different methods for fixture creation
 - Coupon (reference):
1x Open / 1x Short / 1x Open + 1x Short
 - Fix DUT Fix = modelling file created based on:
Coupon only / mated pair / fixture + transmitter
- ▶ Oscilloscope result with and without de-embedding



Find out more

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Thank you!

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